Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/900,496	FREED ET AL.	
Examiner	Art Unit	
Shin-Hon Chen	2131	

SEARCHED					
Class	Subclass	Date	· Examiner		
713	150, 151, 155, 153, 160	8/1/2006	S.C.		
714	4	8/1/2006	S.C.		
709	228	8/1/2006	S.C.		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
713	150,151	8/1/2006	s.c.		
713	153,155	8/1/2006	S.C.		
713	160	8/1/2006	S.C.		
714/4; 709/228		8/1/2006	S.C.		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search)	8/1/2006	S.C.
Inventor name search on EDAN	8/1/2006	S.C.